

Notice of References Cited	Application/Control No. 10/763,800		Applicant(s)/Patent Under Reexamination EOFF ET AL.	
	Examiner John J. Figueroa		Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0013871	01-2003	Mallon et al.	536/84
*	C	US-7,081,439	07-2006	Sullivan et al.	507/269
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	N	WO 03/056130	05-2003	PCT	COUILLET et al.	-----
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NON-PATENT DOCUMENTS

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